

MAXIMUM RATINGS

Rating	Symbol	Value		Unit
Collector-Emitter Voltage	V _{CEO}	15		Vdc
Collector-Base Voltage	V _{CBO}	30		Vdc
Emitter-Base Voltage	V _{EBO}	3.0		Vdc
Collector Current — Continuous	I _C	50		mAdc
		Each Transistor	Total Device	
Total Device Dissipation @ T _A = 25°C Derate above 25°C	P _D	0.65 3.72	1.9 10.88	Watts mW/°C
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	1.3 7.43	4.6 26.3	Watts mW/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	- 65 to + 200		°C

MHQ918

**CASE 632-02, STYLE 1
TO-116**

**QUAD
AMPLIFIER TRANSISTOR**

NPN SILICON

Refer to MD918 for graphs.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage(1) (I _C = 3.0 mAdc, I _B = 0)	V _{(BR)CEO}	15	—	—	Vdc
Collector-Base Breakdown Voltage (I _C = 1.0 μAdc, I _E = 0)	V _{(BR)CBO}	30	—	—	Vdc
Emitter-Base Breakdown Voltage (I _E = 10 μAdc, I _C = 0)	V _{(BR)EBO}	3.0	—	—	Vdc
Collector Cutoff Current (V _{CB} = 15 Vdc, I _E = 0)	I _{CBO}	—	—	10	nAdc

ON CHARACTERISTICS(1)

DC Current Gain (I _C = 0.1 mAdc, V _{CE} = 1.0 Vdc) (I _C = 3.0 mAdc, V _{CE} = 1.0 Vdc) (I _C = 10 mAdc, V _{CE} = 1.0 Vdc)	h _{FE}	— 20 —	110 80 50	— — —	—
Collector-Emitter Saturation Voltage (I _C = 10 mAdc, I _B = 1.0 mAdc)	V _{CE(sat)}	—	0.11	0.4	Vdc
Base-Emitter Saturation Voltage (I _C = 10 mAdc, I _B = 1.0 mAdc)	V _{BE(sat)}	—	0.84	1.0	Vdc

SMALL-SIGNAL CHARACTERISTICS

Current-Gain — Bandwidth Product (I _C = 4.0 mAdc, V _{CE} = 10 Vdc, f = 100 MHz)	f _T	600	850	—	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f = 140 kHz)	C _{obo}	—	0.75	2.0	pF
Input Capacitance (V _{BE} = 0.5 Vdc, I _C = 0, f = 140 kHz)	C _{ibo}	—	1.4	2.5	pF
Noise Figure (I _C = 1.0 mAdc, V _{CE} = 6.0 Vdc, R _S = 400 Ohms, f = 60 MHz)	NF	—	4.0	6.0	dB

(1) Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.